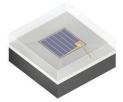
SFH 4170S A01

OSLON® Piccolo

High Power Infrared Emitter (850 nm)





Applications

- Access Control (IRIS/Vein Scan, Face Recognition)
- Driver Monitoring / Seat Occupancy Detection
- Eye Tracking
- Gesture Recognition
- Safety and Security, CCTV

Features:

- Package: clear silicone
- Corrosion Robustness Class: 3B
- Qualifications: AEC-Q102 Qualified
- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM)
- IR lightsource with high efficiency
- Double stack emitter
- Centroid wavelength 850 nm

Ordering Information

Туре	Total radiant flux ¹⁾²⁾	Total radiant flux ¹⁾ typ.	Ordering Code
	$I_{_{\rm F}}$ = 1000 mA; $t_{_{\rm p}}$ = 10 ms $\Phi_{_{\rm e}}$	$I_{p} = 1000 \text{ mA}; t_{p} = 10 \text{ ms}$ Φ_{e}	
SFH 4170S A01	1000 1400 mW	1.15 W	Q65112A9015



Maximum Ratings

T _A = 25 °C			
Parameter	Symbol		Values
Operating temperature	T _{op}	min. max.	-40 °C 105 °C
Storage temperature	T _{stg}	min. max.	-40 °C 105 °C
Junction temperature	T _j	max.	145 °C
Forward current	I _F	max.	1000 mA
Surge current $t_p \le 600 \ \mu s; D = 0.005$	I _{FSM}	max.	2 A
Reverse voltage 3)	V _R	max.	5 V
Power consumption	P _{tot}	max.	3600 mW
ESD withstand voltage acc. to ANSI/ESDA/JEDEC JS-001 (HBM)	V_{ESD}	max.	2 kV

Note: For the forward current and power consumption please see "maximum permissible forward current" diagram.



Characteristics

 I_{F} = 1000 mA; T_{A} = 25 °C

Parameter	Symbol		Values
Peak wavelength	$\lambda_{_{peak}}$	typ.	860 nm
Centroid wavelength	$\lambda_{centroid}$	typ.	850 nm
Spectral bandwidth at 50% I _{rel.max} (FWHM)	Δλ	typ.	30 nm
Half angle	φ	typ.	65 °
Dimensions of chip area	L×W	typ.	0.75 x 0.75 mm x mm
Rise time (10% / 90%) $I_F = 2 \text{ A}; \text{ R}_L = 5 \Omega$	t _r	typ.	9 ns
Fall time (10% / 90%) I _F = 2 A; R _L = 5 Ω	t _f	typ.	16 ns
Forward voltage 4)	V _F	typ. max.	3.25 V 3.6 V
Forward voltage ⁴⁾ $I_F = 2 \text{ A}; t_p = 100 \mu\text{s}$	V _F	typ. max.	3.7 V 4.2 V
Reverse current ³⁾ $V_R = 5 V$	I _R	typ. max.	0.01 μA 10 μA
Radiant intensity ⁵⁾	l _e	typ.	280 mW/sr
Temperature coefficient of voltage	ΤC _v	typ.	-2 mV / K
Temperature coefficient of wavelength	TC _λ	typ.	0.3 nm / K
Thermal resistance junction solder point electrical $^{\rm 6)}$ with efficiency $\eta_{\rm e}$ = 38 %	R _{thJS elec.}	typ. max.	6.8 K / W 8.1 K / W
Thermal resistance junction solder point real ⁶⁾	$R_{thJS real}$	typ. max.	11.0 K / W 13.0 K / W

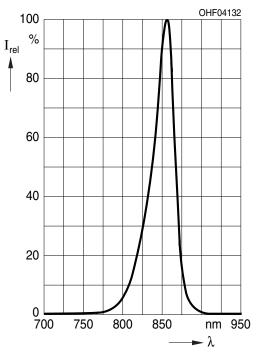


Brightness Groups

Group	Total radiant flux ¹⁾²⁾ $I_F = 1 A; t_p = 10 ms$ min.	Total radiant flux ¹⁾²⁾ $I_F = 1 \text{ A}; t_p = 10 \text{ ms}$ max.	
	Ф _е	Ф _е	
EB2	1000 mW	1120 mW	
FA1	1120 mW	1250 mW	
FA2	1250 mW	1400 mW	

Relative Spectral Emission 7), 8)

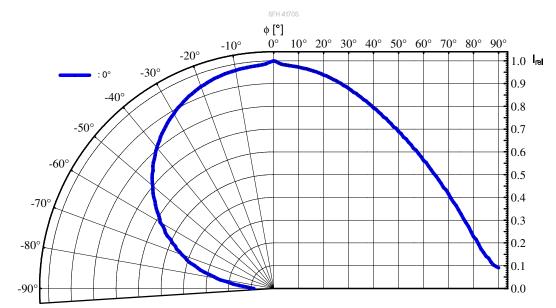
 $I_{e,rel} = f(\lambda); I_{F} = 1000 \text{ mA}; t_{p} = 10 \text{ ms}$





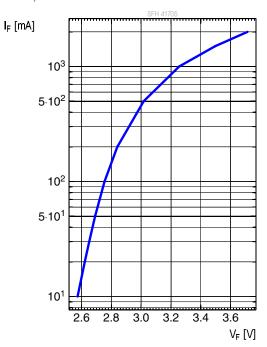
Radiation Characteristics 7), 8)

 $I_{e,rel} = f(\phi)$



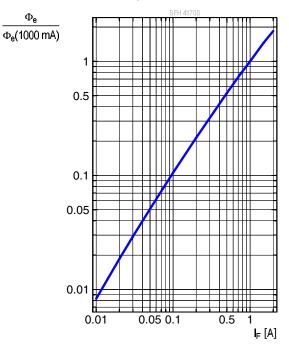
Forward current ^{7), 8)}

 $I_{F} = f(V_{F}); t_{p} = 100 \ \mu s$



Relative Total Radiant Flux 7), 8)

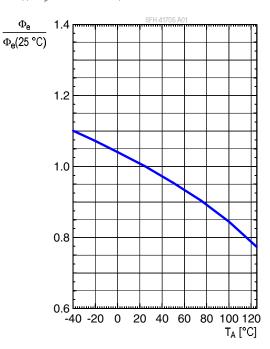
 $\Phi_{e}/\Phi_{e}(1000\text{mA}) = f(I_{F}); t_{p} = 100 \ \mu\text{s}$





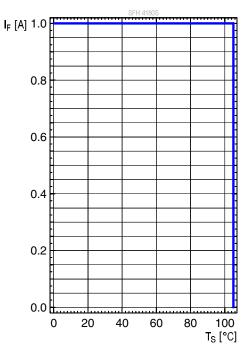
Relative Total Radiant Flux⁷⁾

 Φ_{e} = f (T_A); t_p = 100 µs; I_F = 1000 mA



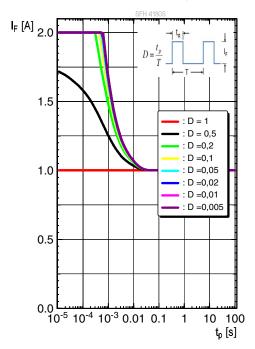
Max. Permissible Forward Current

 $I_{F,max} = f(T_A);$



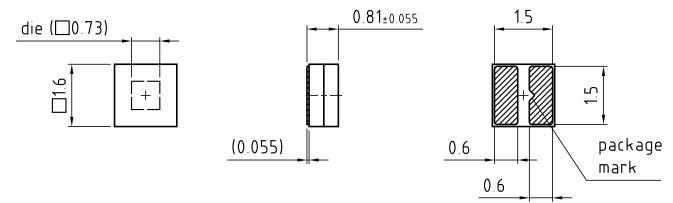
Permissible Pulse Handling Capability

 $I_{_{\rm F}}$ = f (t_p); duty cycle D = parameter; T_s = 85°C





Dimensional Drawing ⁹⁾



general tolerance ± 0.05 lead finish Au 🜌

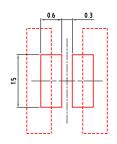
C63062-A4399-A1-04

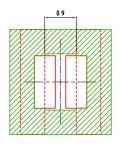
Further Information:

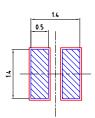
Approximate Weight:	6.2 mg
Package marking:	Cathode
Corrosion test:	Class: 3B Test condition: 40°C / 90 % RH / 15 ppm $\rm H_2S$ / 14 days (stricter than IEC 60068-2-43)



Recommended Solder Pad⁹⁾







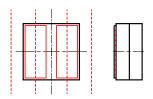








Component Location on Pad



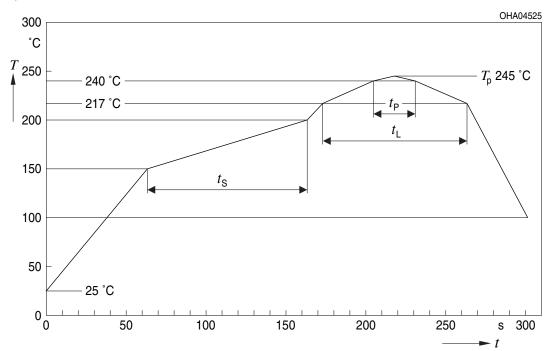


E062.3010.272 -01



Reflow Soldering Profile

Product complies to MSL Level 2 acc. to JEDEC J-STD-020E



Profile Feature	Symbol	Pb-Free (SnAgCu) Assembly			Unit
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat ^{*)} 25 °C to 150 °C			2	3	K/s
Time t _s T _{smin} to T _{smax}	t _s	60	100	120	S
Ramp-up rate to peak ^{*)} T_{smax} to T_{p}			2	3	K/s
Liquidus temperature	TL		217		°C
Time above liquidus temperature	t		80	100	S
Peak temperature	Τ _Ρ		245	260	°C
Time within 5 °C of the specified peak temperature T_p - 5 K	t _P	10	20	30	S
Ramp-down rate* T _P to 100 °C			3	6	K/s
Time 25 °C to T _P				480	S

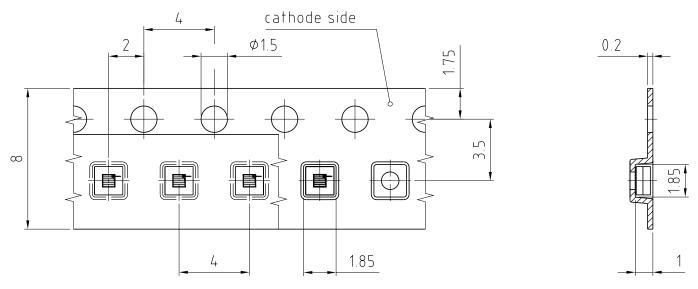
All temperatures refer to the center of the package, measured on the top of the component

* slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range



SFH 4170S A01

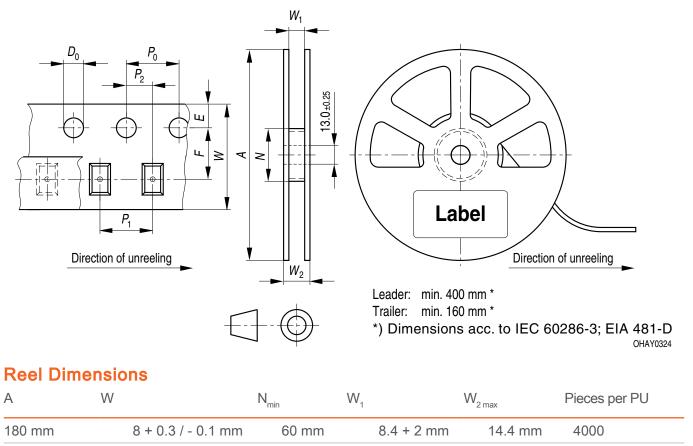
Taping ⁹⁾



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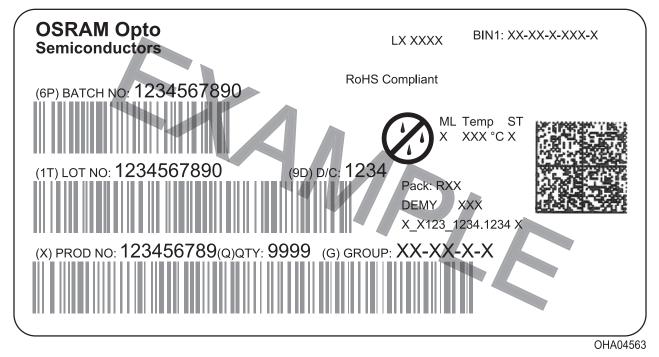


Tape and Reel ¹⁰⁾

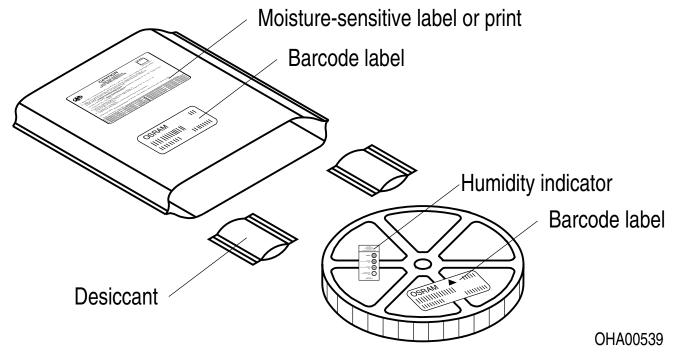




Barcode-Product-Label (BPL)



Dry Packing Process and Materials





Notes

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the device specified in this data sheet falls into the class **exempt group (exposure time 10000 s)**. Under real circumstances (for exposure time, conditions of the eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. When looking at bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this device contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize device exposure to aggressive substances during storage, production, and use. Devices that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

Handling:

Solvents, water, liquids, non-conductive plastics and glues are not allowed near the device, because solvents and other liquids could emerge and damage the product.

For further application related information please visit www.osram-os.com/appnotes



Disclaimer

Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact our Sales Organization.

If printed or downloaded, please find the latest version on the OSRAM OS website.

Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Product and functional safety devices/applications or medical devices/applications

OSRAM OS components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

OSRAM OS products are not qualified at module and system level for such application.

In case buyer – or customer supplied by buyer – considers using OSRAM OS components in product safety devices/applications or medical devices/applications, buyer and/or customer has to inform the local sales partner of OSRAM OS immediately and OSRAM OS and buyer and /or customer will analyze and coordinate the customer-specific request between OSRAM OS and buyer and/or customer.



Glossary

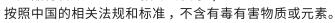
- ¹⁾ **Total radiant flux:** Measured with integrating sphere.
- ²⁾ **Brightness:** The brightness values are measured with a tolerance of $\pm 11\%$.
- ³⁾ **Reverse Operation:** This product is intended to be operated applying a forward current within the specified range. Applying any continuous reverse bias or forward bias below the voltage range of light emission shall be avoided because it may cause migration which can change the electro-optical characteristics or damage the LED.
- ⁴⁾ **Forward Voltage:** The forward voltages are measured with a tolerance of ±0.1 V.
- ⁵⁾ **Radiant intensity:** Measured at a solid angle of Ω = 0.01 sr
- ⁶⁾ **Thermal resistance:** junction soldering point, of the device only, mounted on an ideal heatsink (e.g. metal block)
- ⁷⁾ Typical Values: Due to the special conditions of the manufacturing processes of semiconductor devices, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- ⁸⁾ **Testing temperature:** TA = 25°C (unless otherwise specified)
- ⁹⁾ **Tolerance of Measure:** Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- ¹⁰⁾ **Tape and Reel:** All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



Revision History		
Version	Date	Change
1.0	2020-04-09	Initial Version
1.0	2020-05-13	Brand



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